

Frequency tuning effect on the bremsstrahlung spectra, beam intensity and shape in a 10 GHz, permanent magnet ECR ion source

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Outline

1 Introduction

- Overview of Accelerator and Ion Sources
- Frequency tuning technique
- Advantages of the frequency tuning technique
- Observations in various ECR ion sources

2 Experimental details

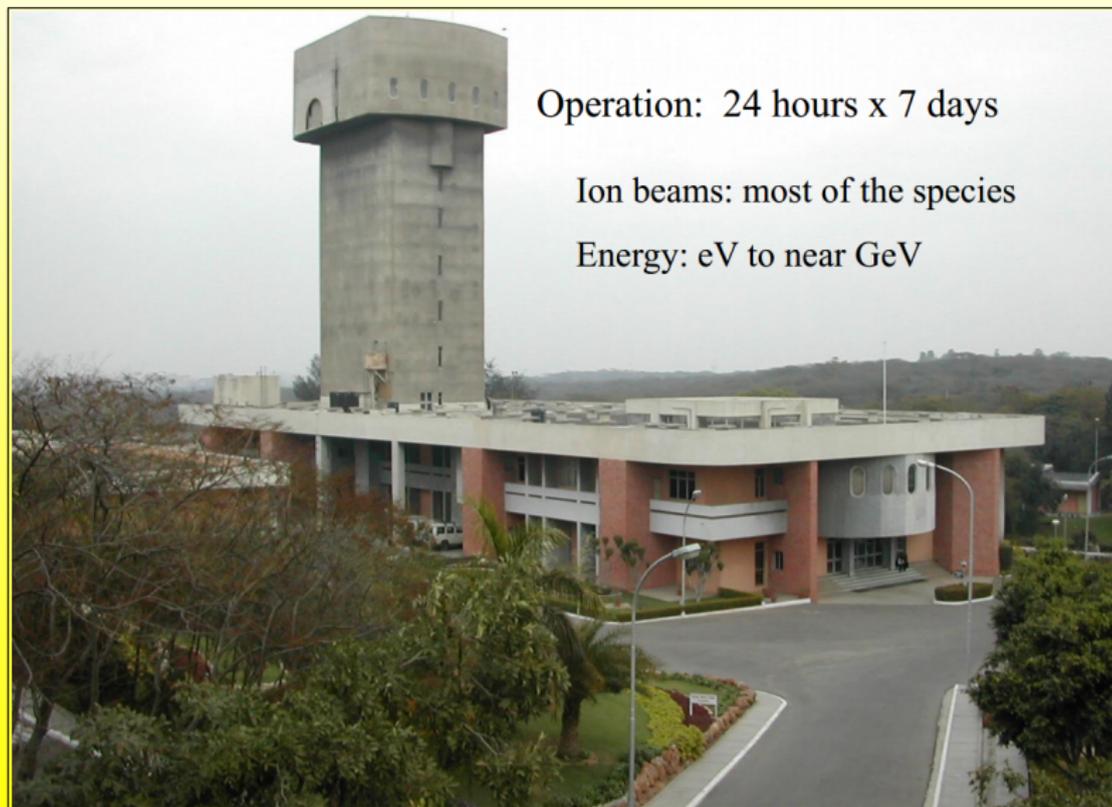
- Ion source and beamline
- Details of the ECR cavity
- X-ray measurement set-up
- Measurements of x-rays and beam intensities
- Beam shape measurements

3 3D simulations using CST Microwave Studio

- Description of CST Particle Studio
- CST model of the 10 GHz NANOGAN ECR Source
- Particle tracking for TE_{117} mode
- Particle tracking at 10.46 GHz

4 Conclusions

View of the Inter University Accelerator Centre



Operation: 24 hours x 7 days

Ion beams: most of the species

Energy: eV to near GeV

15 UD Pelletron at IUAC, New Delhi

15UD Pelletron Accelerator at IUAC

Tank height: 26.5 m

Diameter: 5.5 m

Pressure: 86 PSI

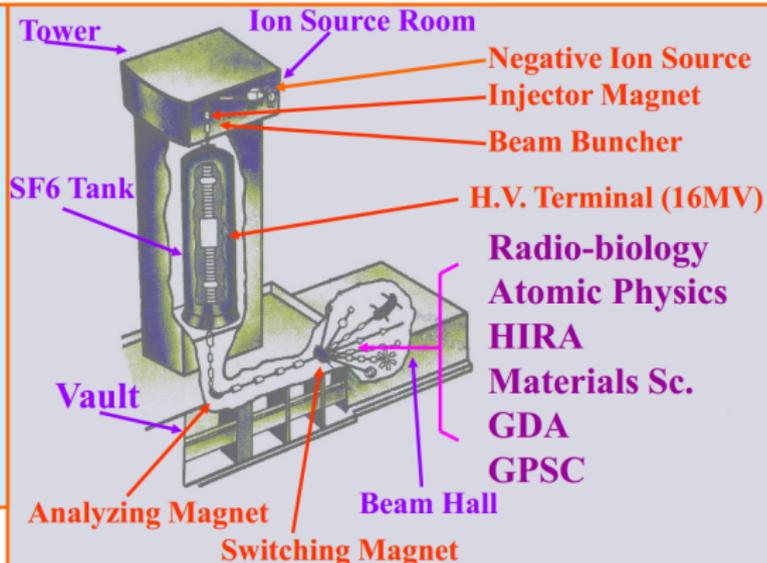
SF₆ gas

Ions accelerated:

H to Au beams

Currents: ~ 1 -50 pA

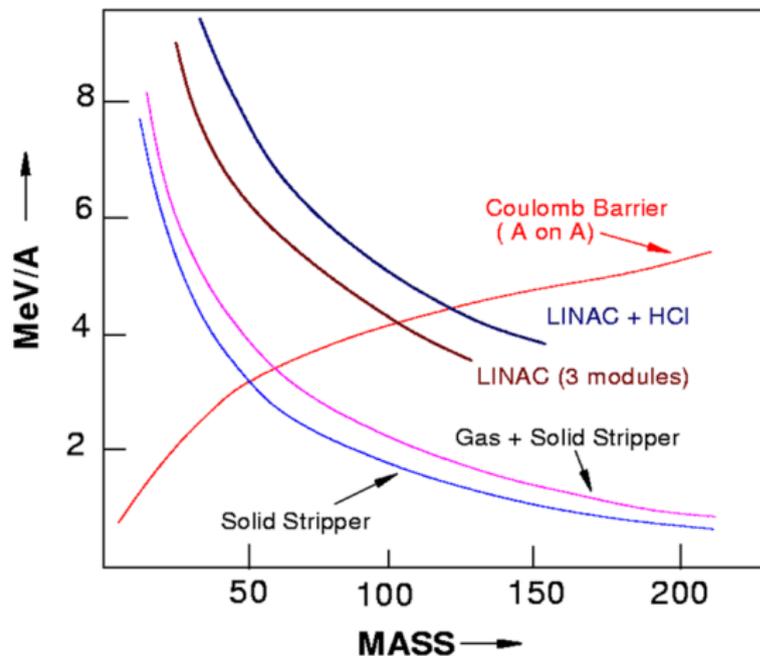
Energy : 30 – 270 MeV



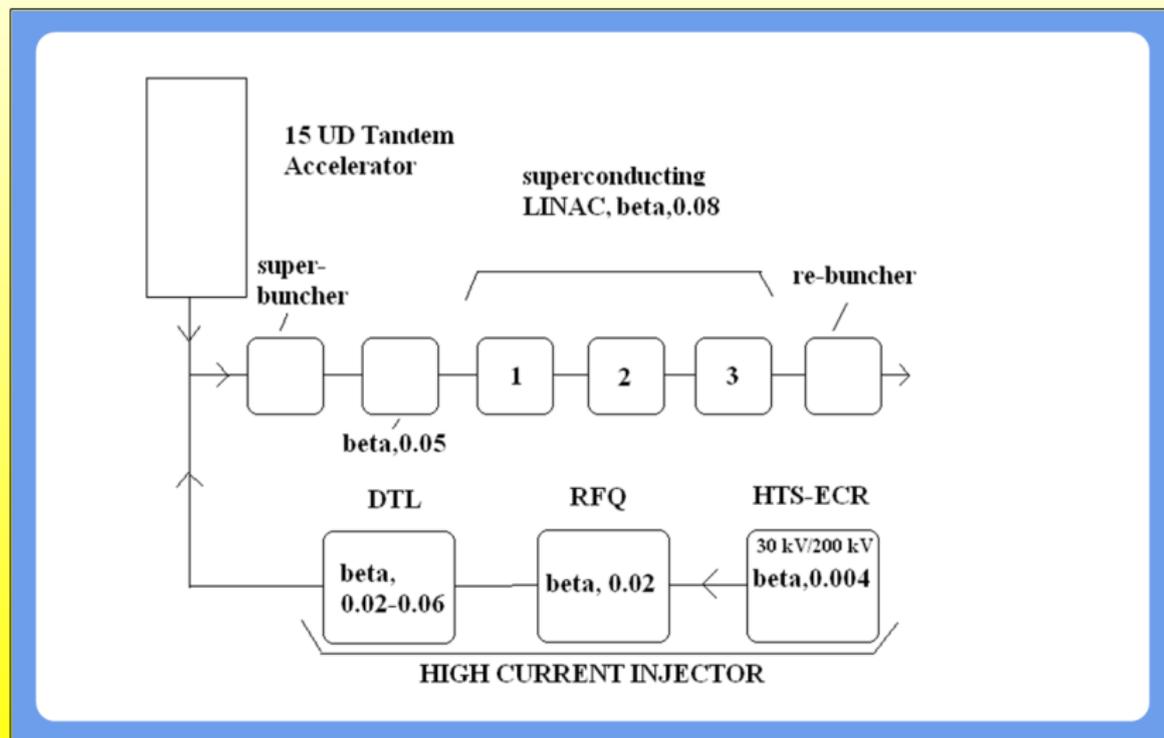
Special Features:

1. Off-set QP in Terminal
2. Earthquake Protection
3. Compressed Geometry Tubes

Development of a High Current Injector



Schematic of High Current Injector

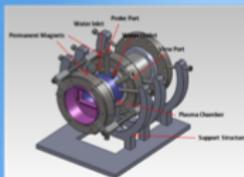


Status of Beam Hall III

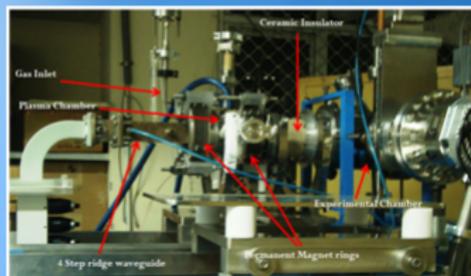


Status of ECR/Microwave Sources

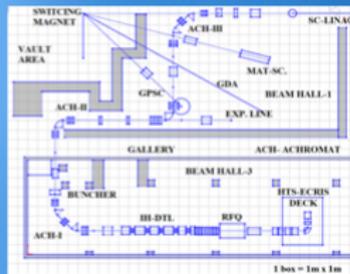
10 GHz NANOGAN



2.45 GHz Microwave Source Development

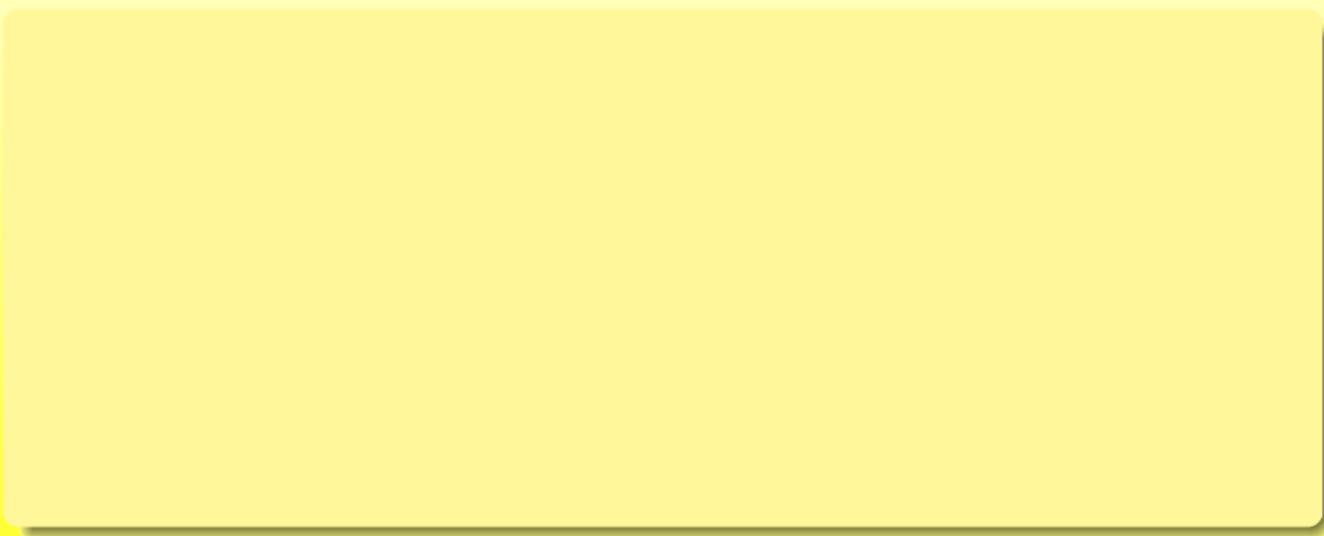


18 GHz HTS-ECRIS, PKDELIS & LEBT



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- The performance of an ECRIS is critically dependant on the resonant absorption of microwave power.

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- Constant endeavour to improve the beam quality, intensity and stability

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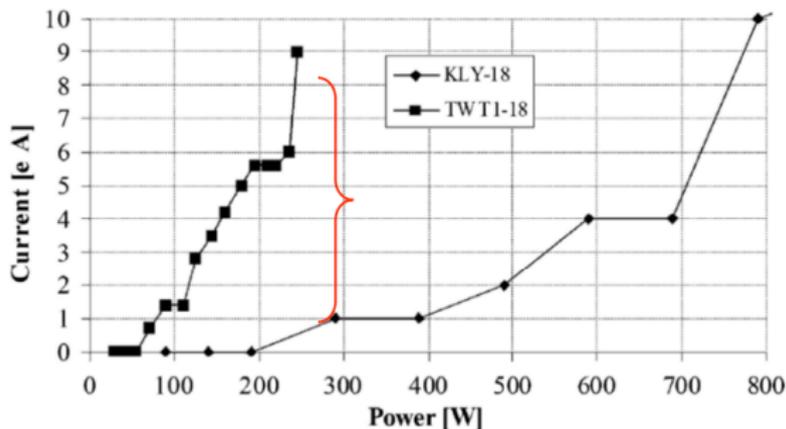
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- Variable frequency microwave generators can be used
- Efficiency of beam extraction is enhanced

First indications of Frequency Tuning Effect

Signs about the importance of the frequency tuning effect came already in 2004 from an experiment carried out on SERSE [A. Galatà, Tesi di Laurea]



Comparison between trends of O^{8+} at 18 GHz for klystron (up to 800 W) and TWT1 operating in the same range of frequency.

TWT



BROADBAND GENERATOR?

Courtesy: S.Gammino

Frequency tuning effect in various ECR ion sources



V. Toivanen et al., Rev. Sci. Instrum.81, 02A319 (2010)

Frequency tuning effect in various ECR ion sources

- In few of the experiments performed, the formation of hollow beams was observed just after source extraction before the solenoid focusing element

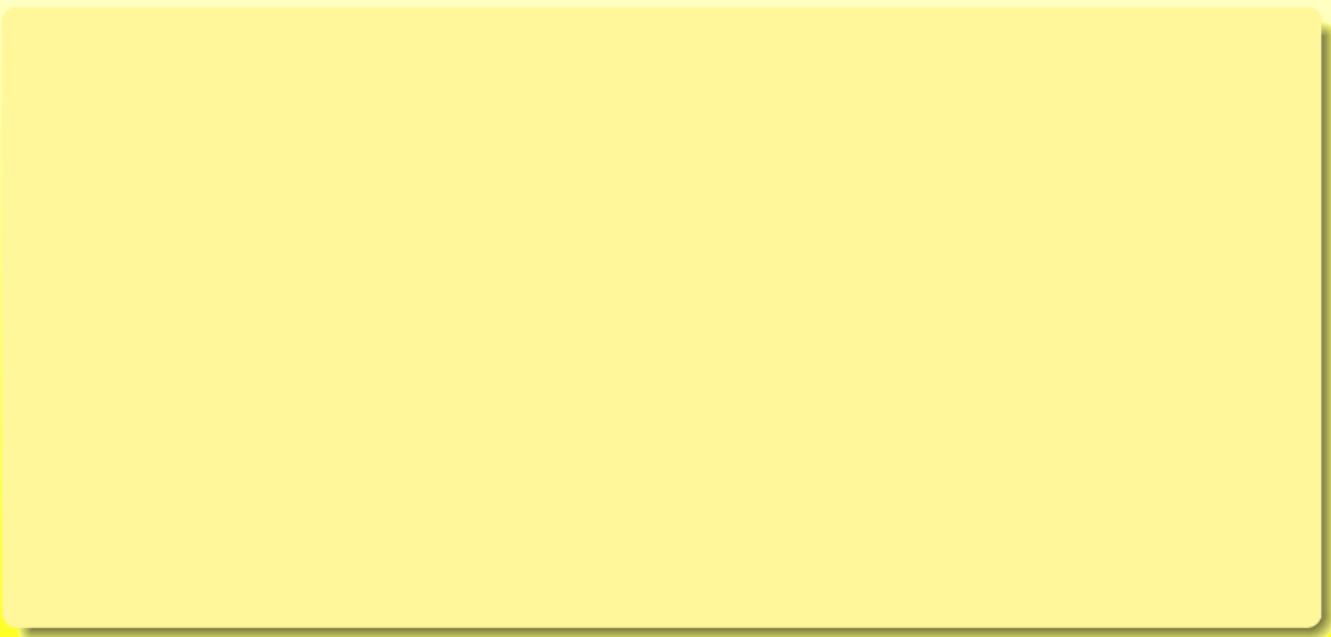
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Frequency tuning effect in various ECR ion sources

- In few of the experiments performed, the formation of hollow beams was observed just after source extraction before the solenoid focusing element
- Reason: space charge effects or/and due to mode parameters $TE_{n,l,m}$ where $n, l > 1$
- Understanding bremsstrahlung spectrum of cold, warm, and hot electrons, and the electron distribution function is necessary to study how characteristics of the beam are influenced by the frequency tuning.

V. Toivanen et al., Rev. Sci. Instrum.81, 02A319 (2010)

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S. Gammino et al., Proceedings of CYCLOTRONS, Lanzhou, China, 2010

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Frequency tuning effect in various ECR ion sources

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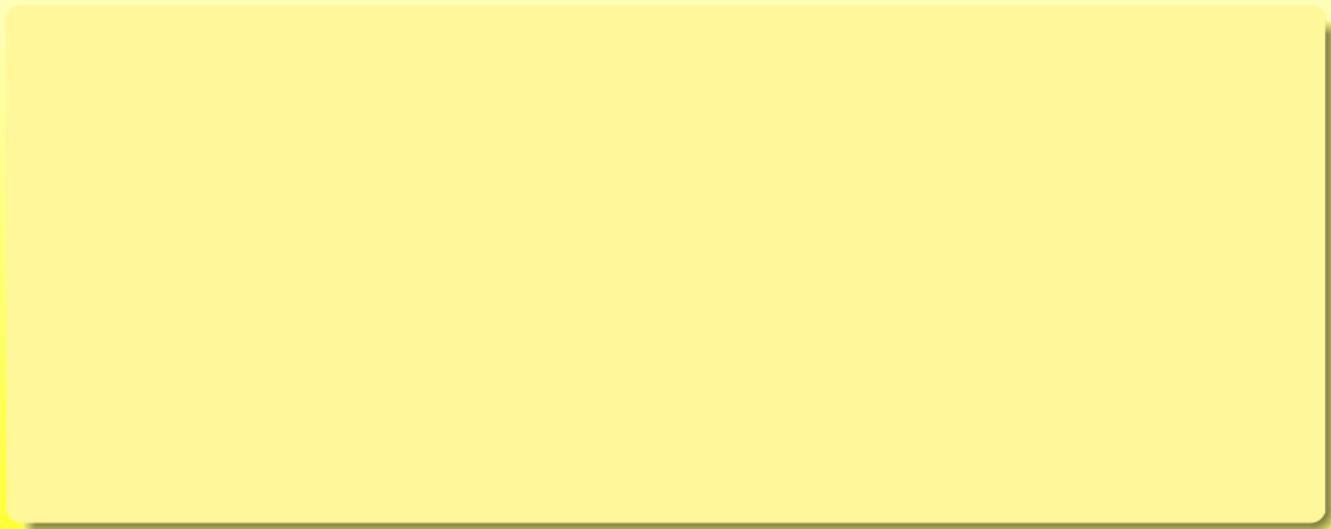
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- Distinguish between microwave generator to plasma chamber coupling and excited mode to plasma coupling
- Mode spatial structure plays the main role in ECRIS

S. Gammino et al., Proceedings of CYCLOTRONS, Lanzhou, China, 2010

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Frequency tuning effect in various ECR ion sources



G.Rodrigues et al., Rev. Sci. Instrum.85, 02A944 (2014)

Frequency tuning effect in various ECR ion sources

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- Measurement of bremsstrahlung spectra may give further information on the distribution of cold and warm electrons which can explain the probable ionization processes

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- At IUAC, New Delhi, a compact 10 GHz NANOGAN ECR ion source was used

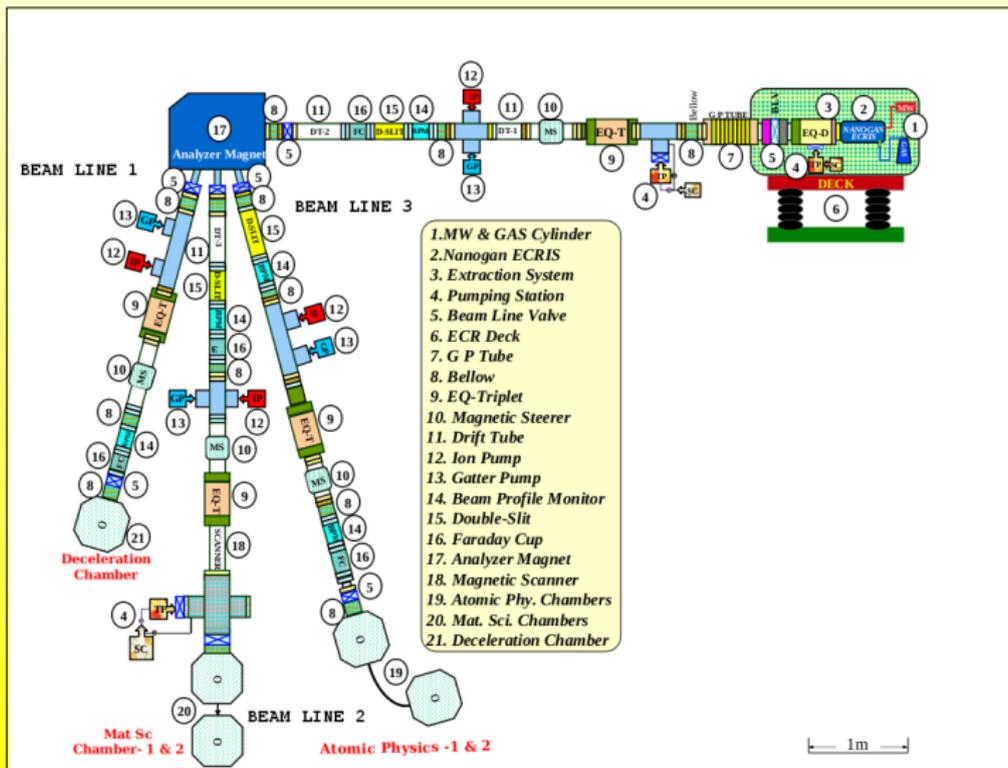
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- Measurement of bremsstrahlung spectra may give further information on the distribution of cold and warm electrons which can explain the probable ionization processes
- At IUAC, New Delhi, a compact 10 GHz NANOGAN ECR ion source was used
- The frequency tuning effect on the beam intensity, shape and bremsstrahlung spectra were studied

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Low Energy Ion Beam Facility



View of the 400 kV platform



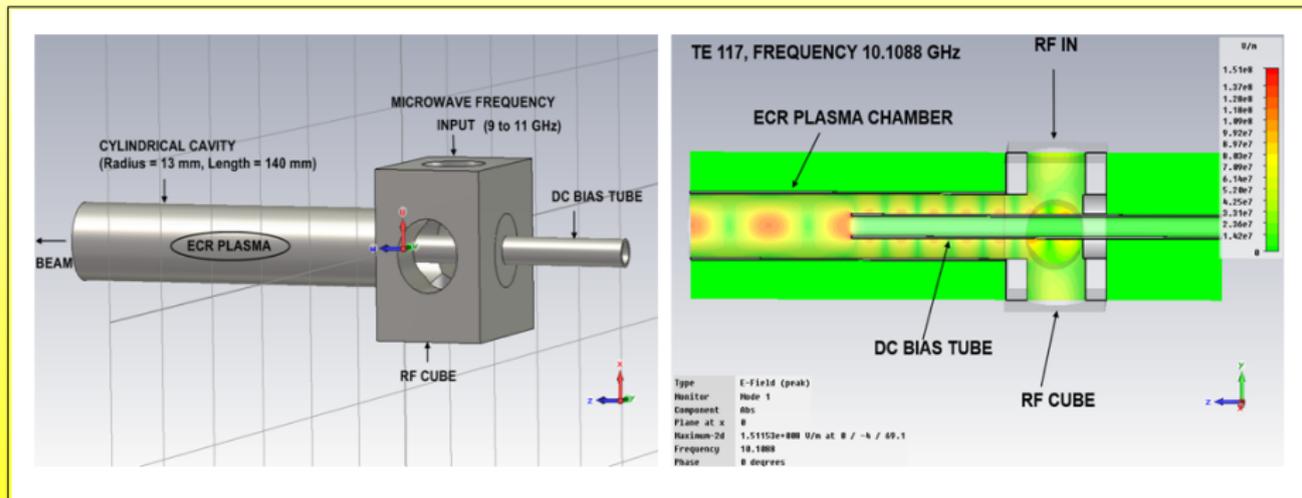
View of the experimental beamlines



10 GHz NANOGAN ECR source on 400 kV platform



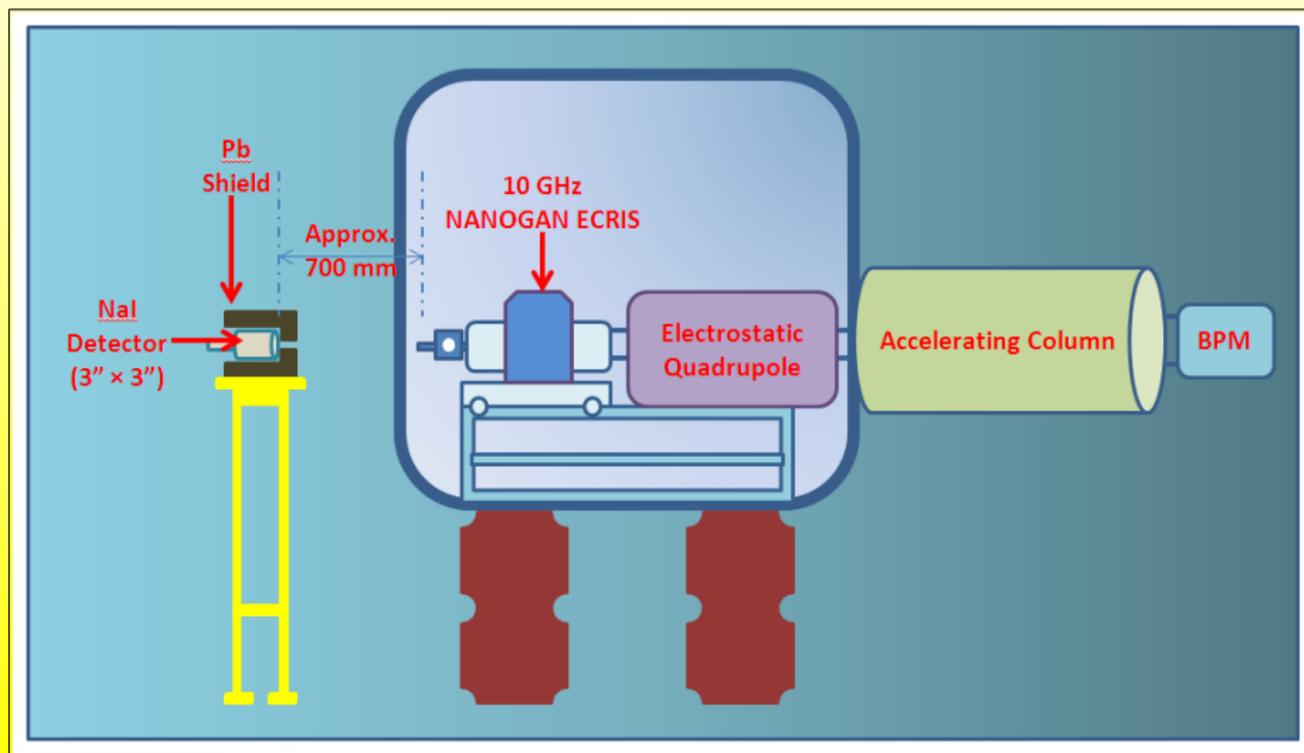
Model of the ECR cavity, calculation of dominant mode



Vacuum modes of the cavity

Mode type	Calculated frequency (GHz)
TM ₀₁₂	9.0823955987
TE ₁₁₆	9.3238928884
TM ₀₁₃	9.3926442931
TM ₀₁₄	9.8105232596
TE ₁₁₇	10.0914719844
TM ₀₁₅	10.3229699816
TE ₁₁₈	10.9102418779
TM ₀₁₆	10.9166750733

X-ray measurement set-up



Details of experiment

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- Experiments were performed for two beams, ^{16}O and ^{40}Ar

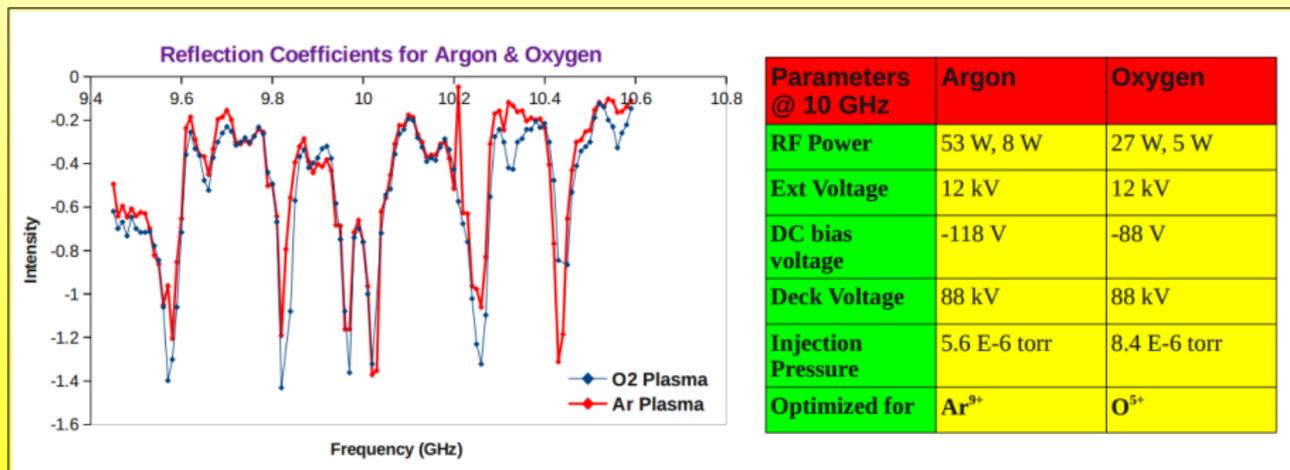
Details of experiment

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- Frequency was varied from ~ 9.5 to 10.5 GHz

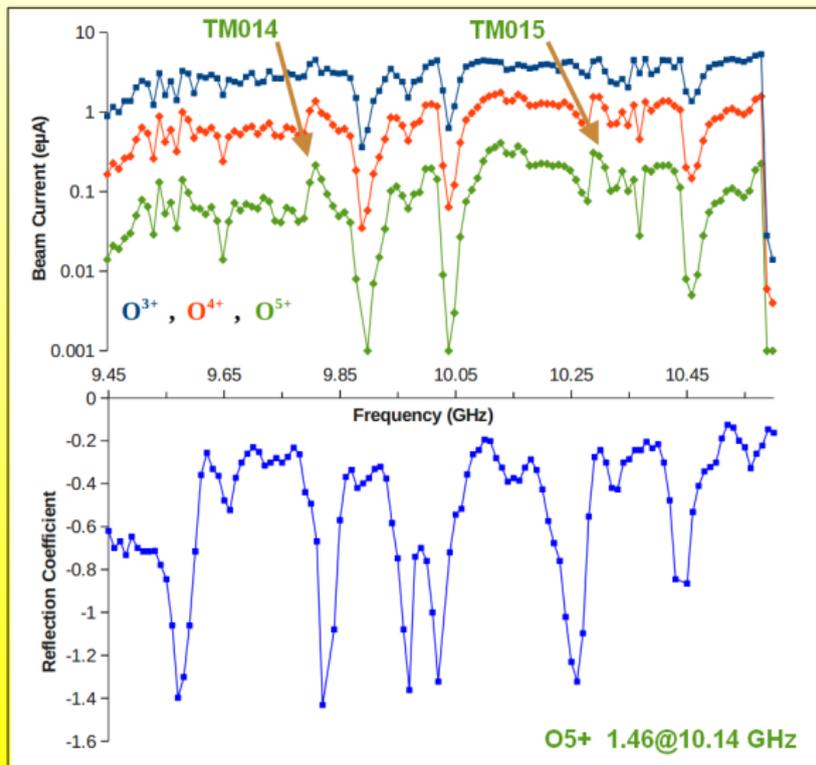
Details of experiment

- Experiments were performed for two beams, ^{16}O and ^{40}Ar
- Frequency was varied from ~ 9.5 to 10.5 GHz
- Beam currents, x-ray and beam shapes were measured

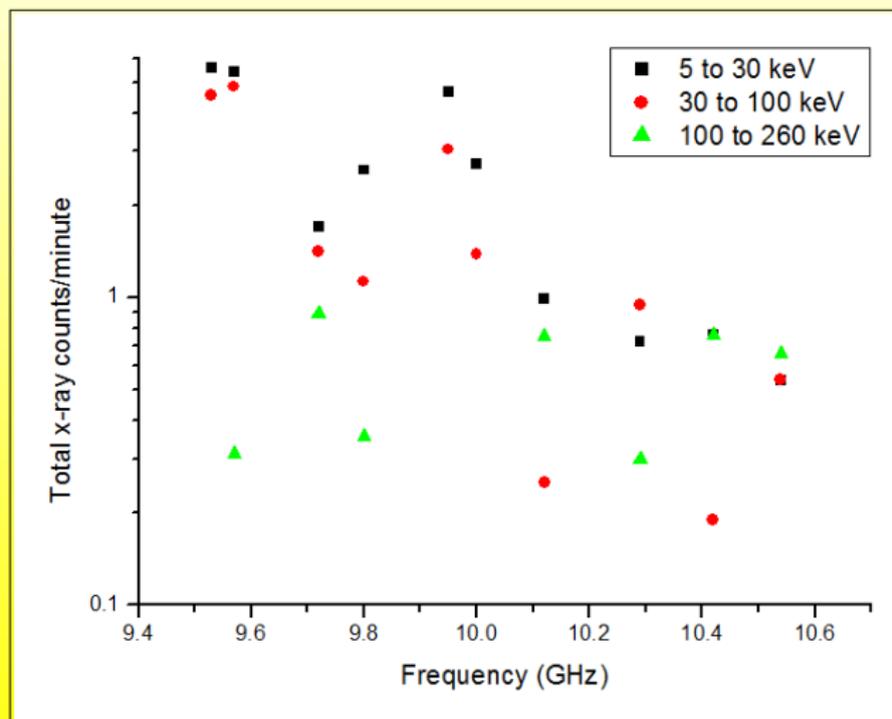
Reflection co-efficient for two plasmas



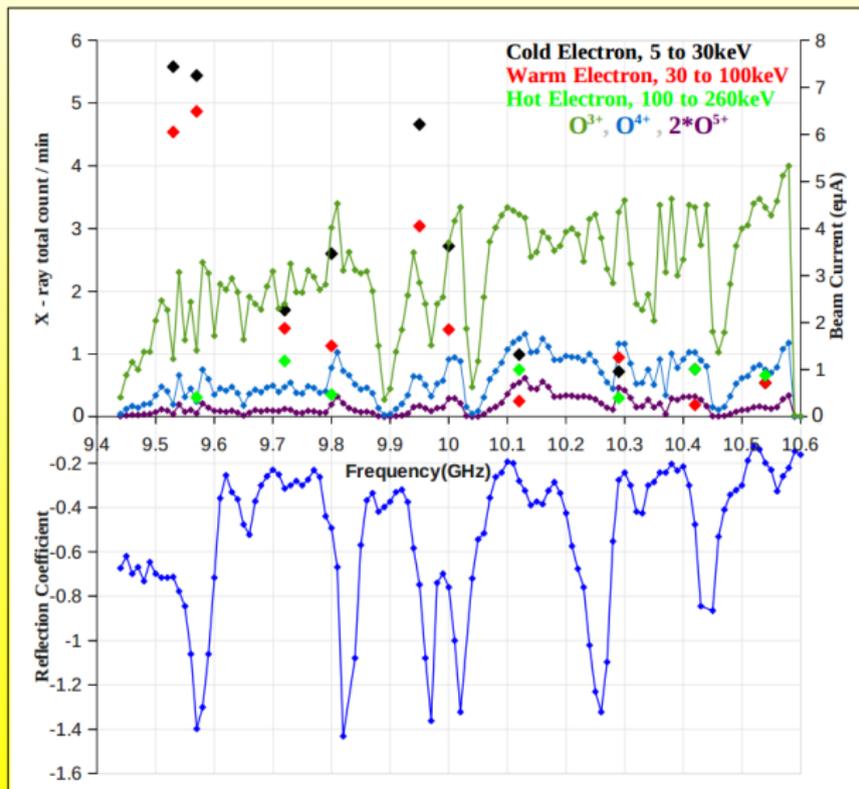
Measurements with oxygen plasma



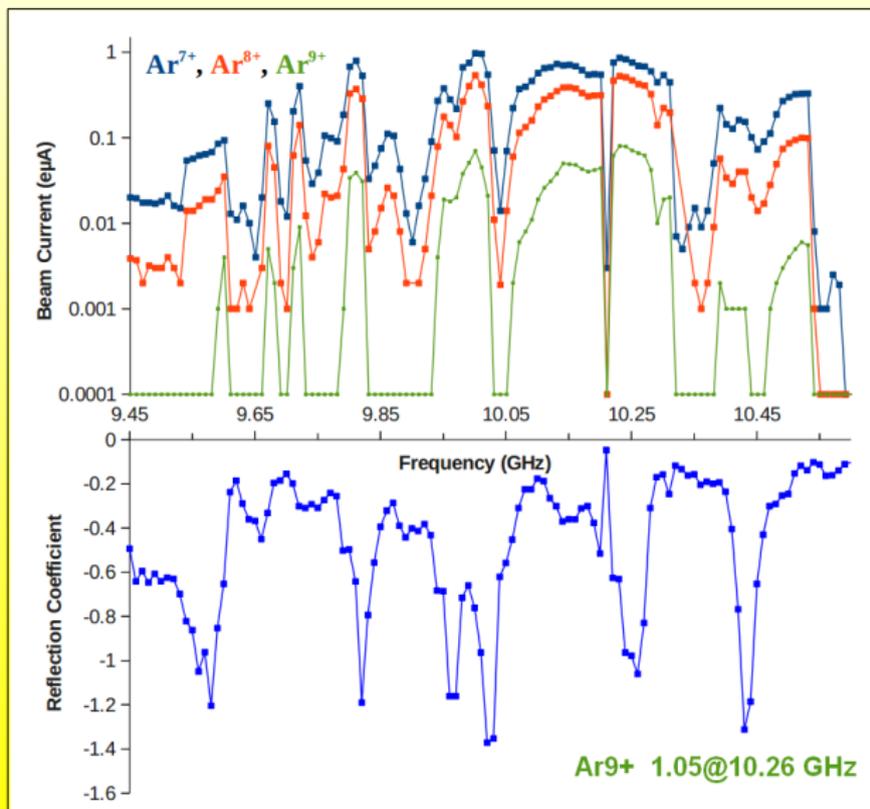
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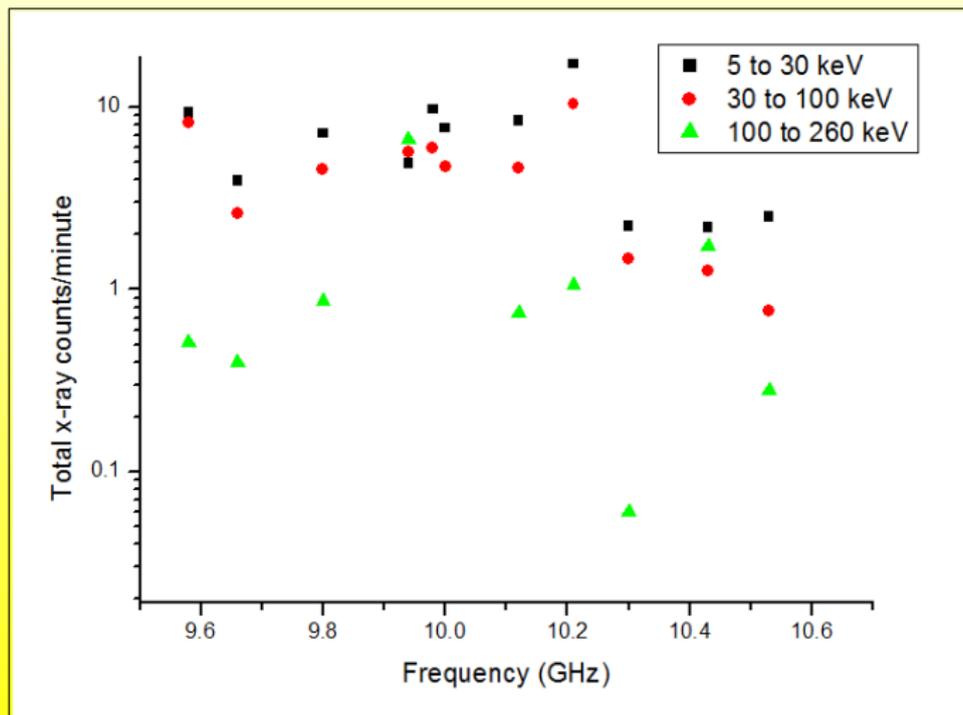
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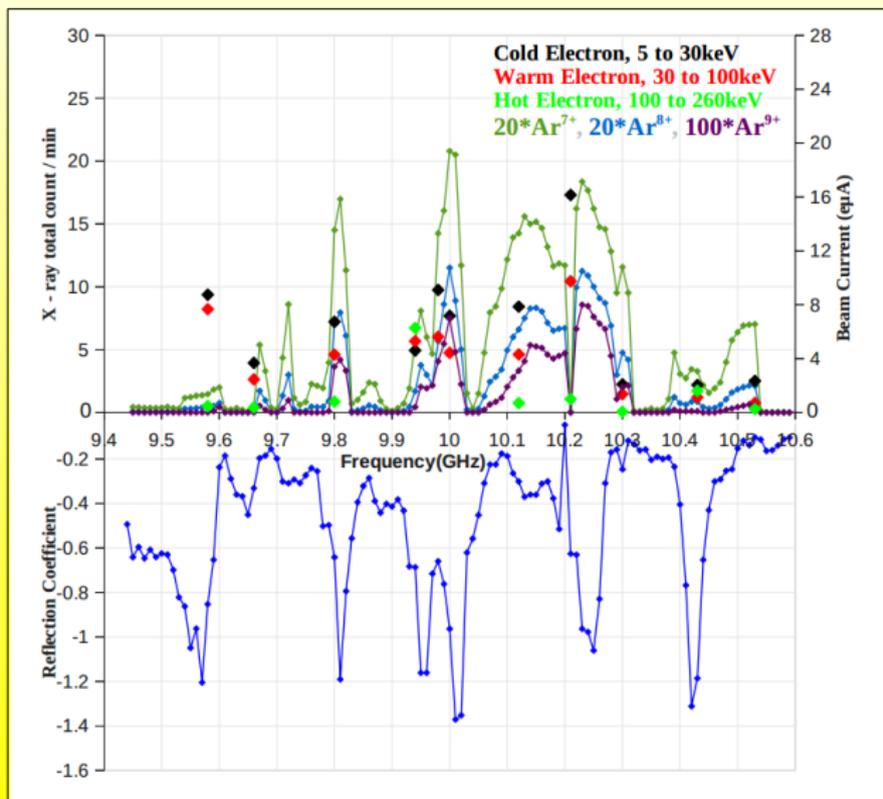
Measurements with argon plasma



Measurements with argon plasma

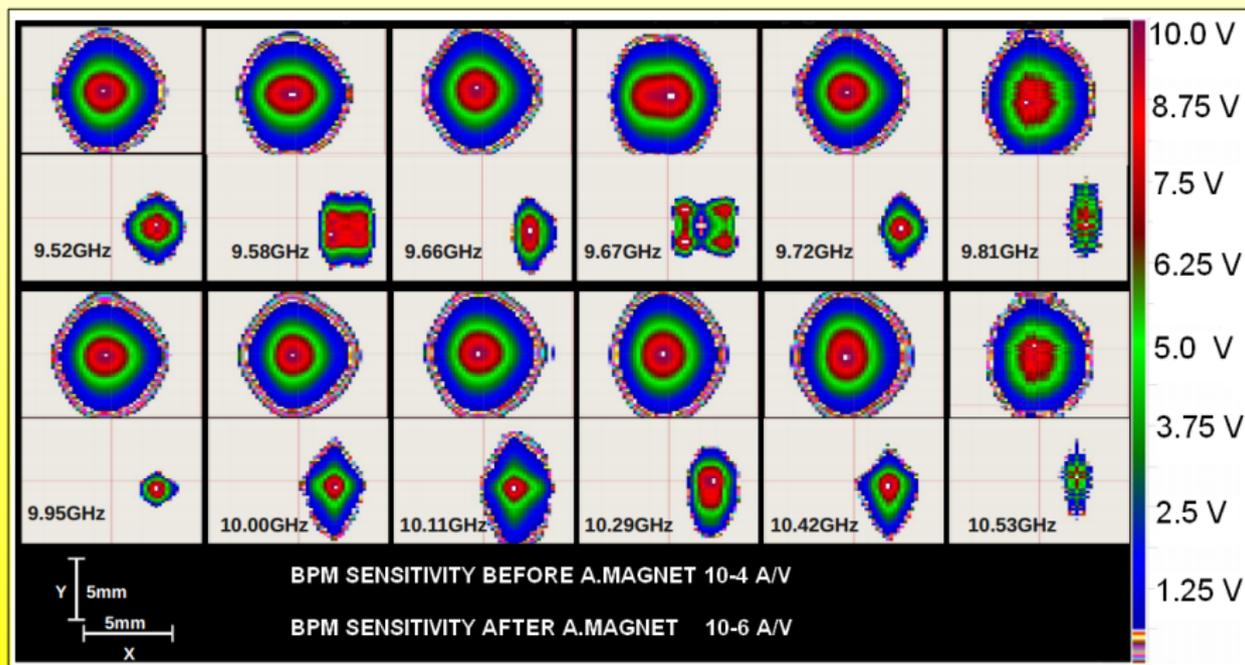


Measurements with argon plasma

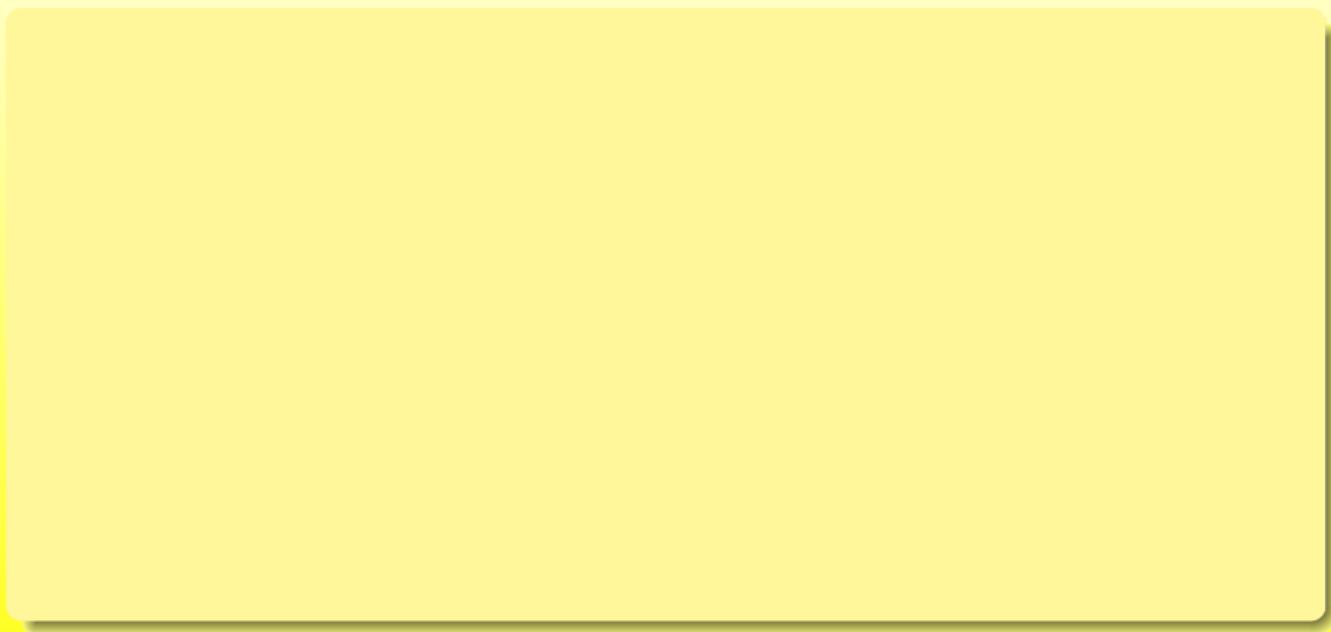


Calculated and observed frequencies

From 9 to 11 GHz		Observed Resonance frequencies(GHz)	
Mode Type	Calculated Mode (GHz)	Argon Plasma	Oxygen Plasma
TM 012	9.0823955987	9.60	9.58
TE 116	9.3238928884	9.67	9.66
TM 013	9.3926442931	9.72	9.73
TM 014	9.8105232596	9.81	9.81
TE 117	10.0914719844	9.95	9.94
TM 015	10.3229699816	10.00	10.02
TE 118	10.9102418779	10.13	10.10
TM 016	10.9166750733	10.23	10.21
		10.30	10.30
		10.39	10.38
		10.42	10.41
		10.53	10.58

Digitised beam shapes at various frequencies for O^{5+} 

CST Particle Studio



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- Incorporates powerful electromagnetic field solvers for calculating the external fields, an efficient particle tracking algorithm and sophisticated emission models

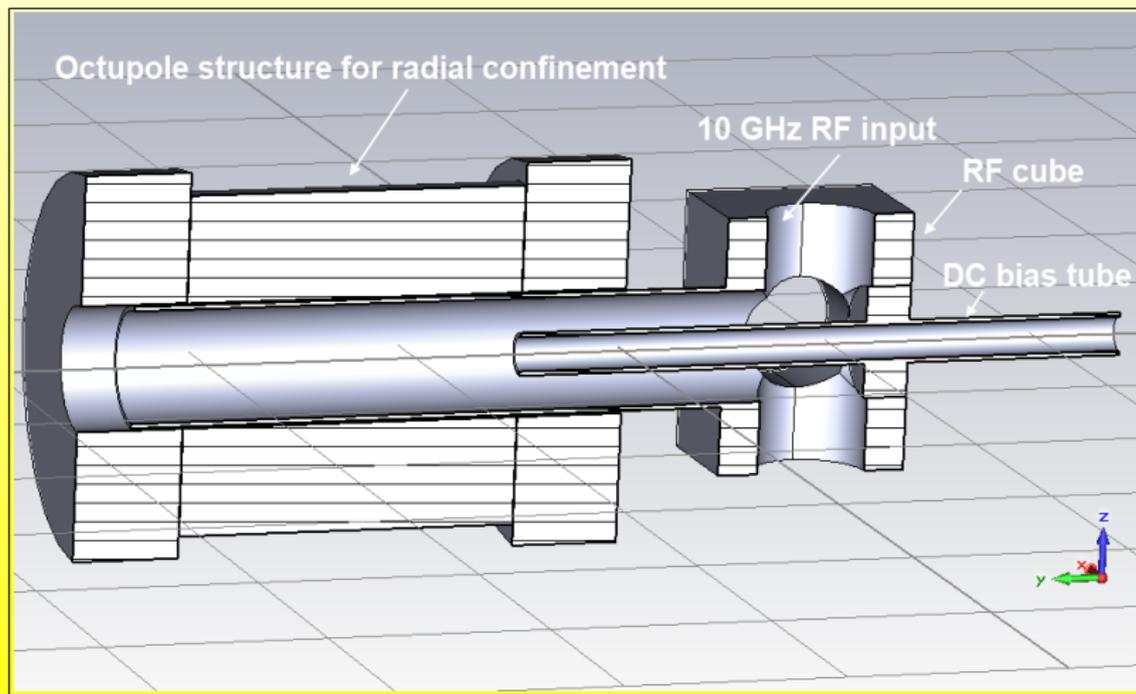
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- The magnetic fields are imported from the magneto-static solver to solve the motion of the electrons at specific calculated modes of the cavity.

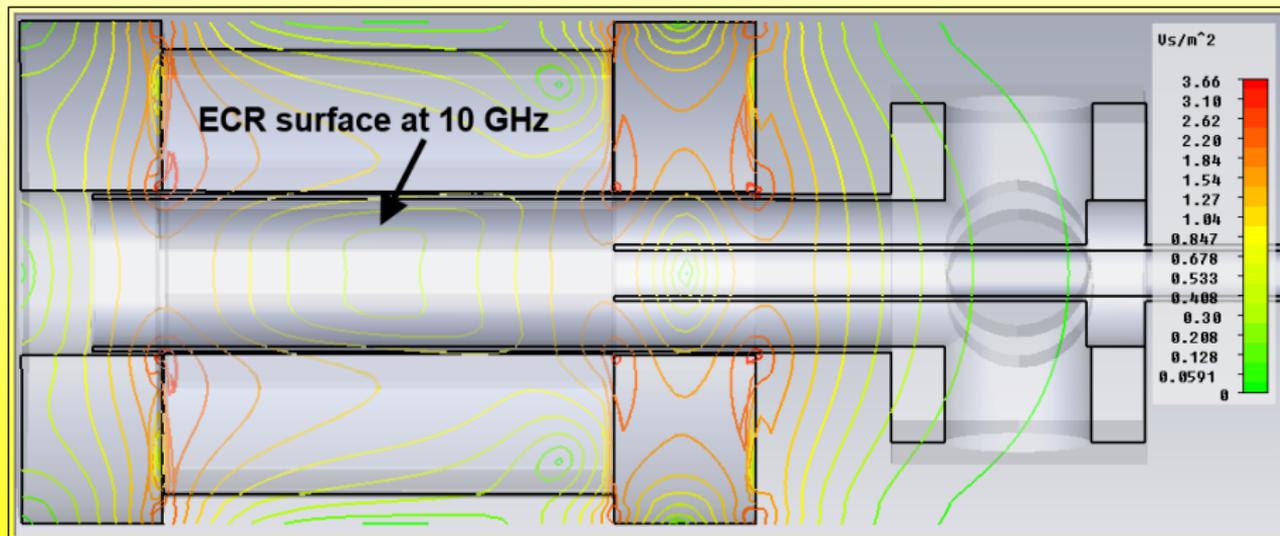
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- The particles are pushed through the computational domain by interpolating the field values to their location and calculating the EM forces

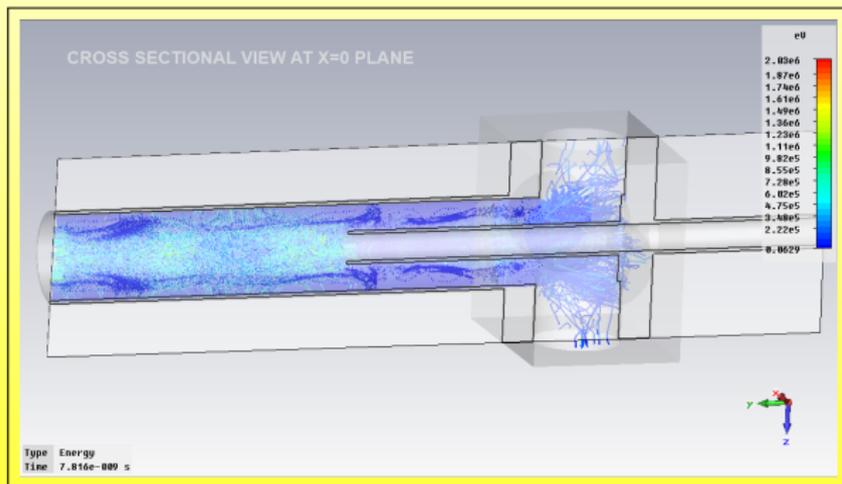
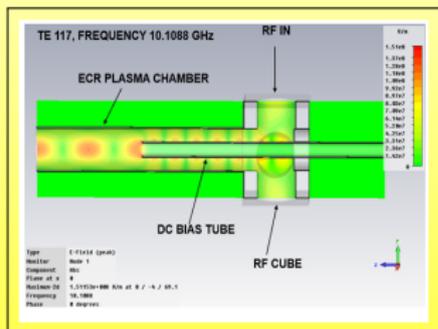
Model of permanent magnet ECR source



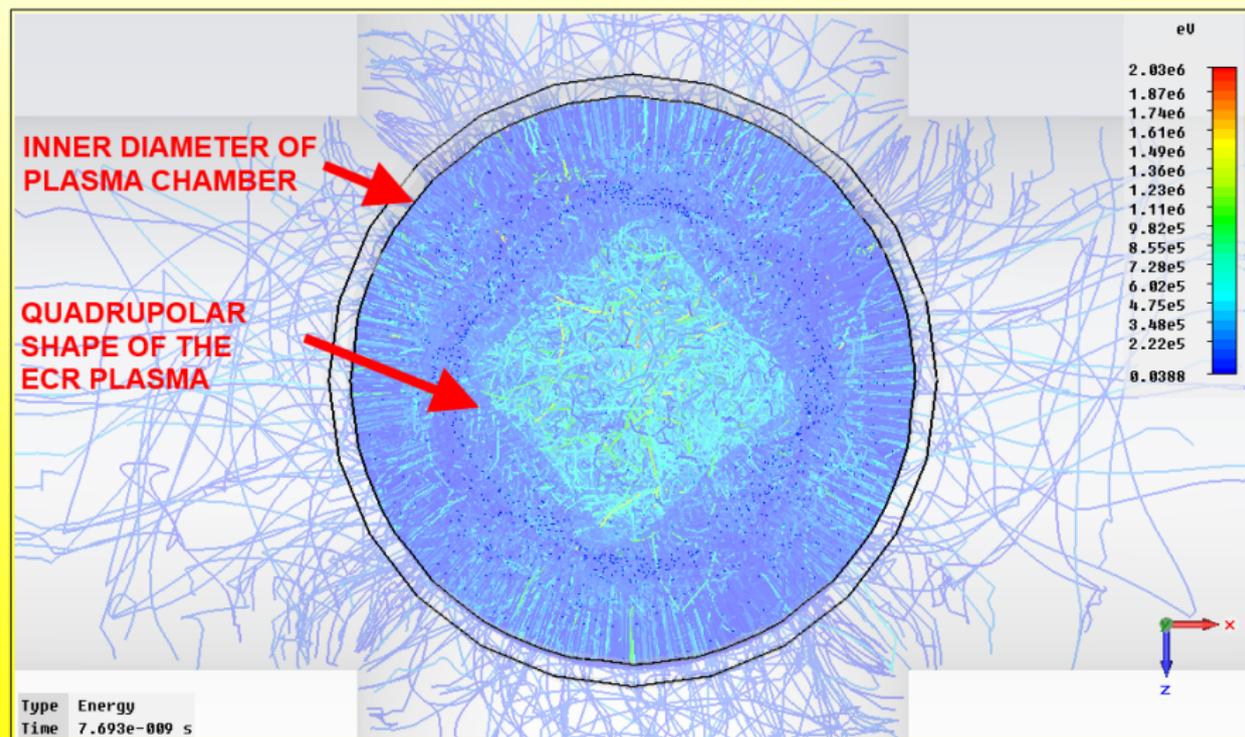
Magnetic field calculation



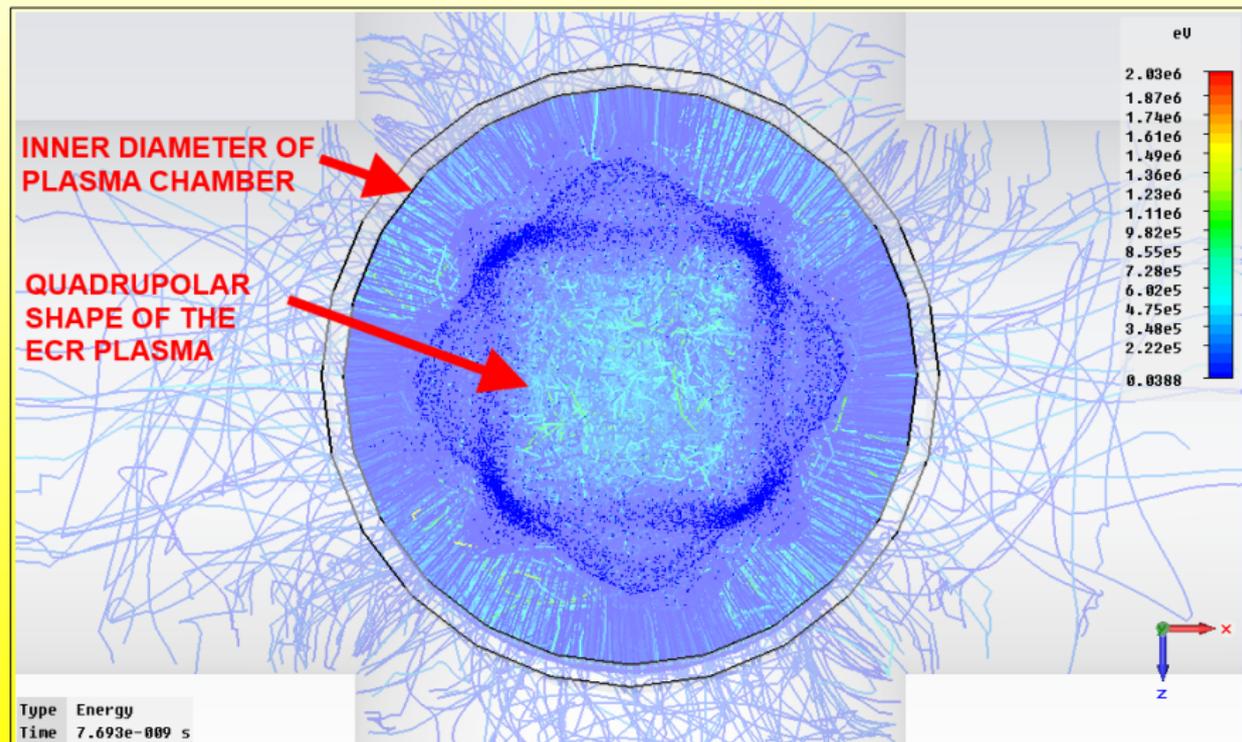
Longitudinal view



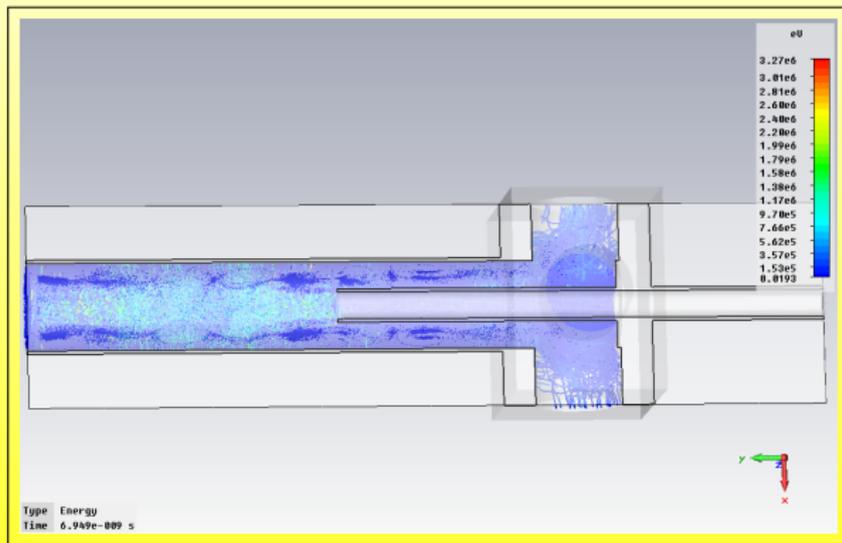
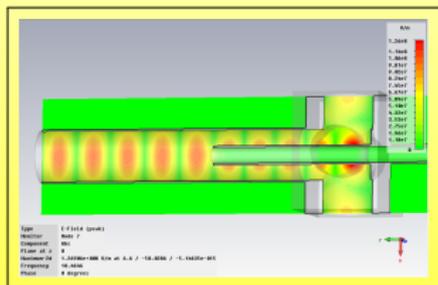
View of the electron trajectories at injection side



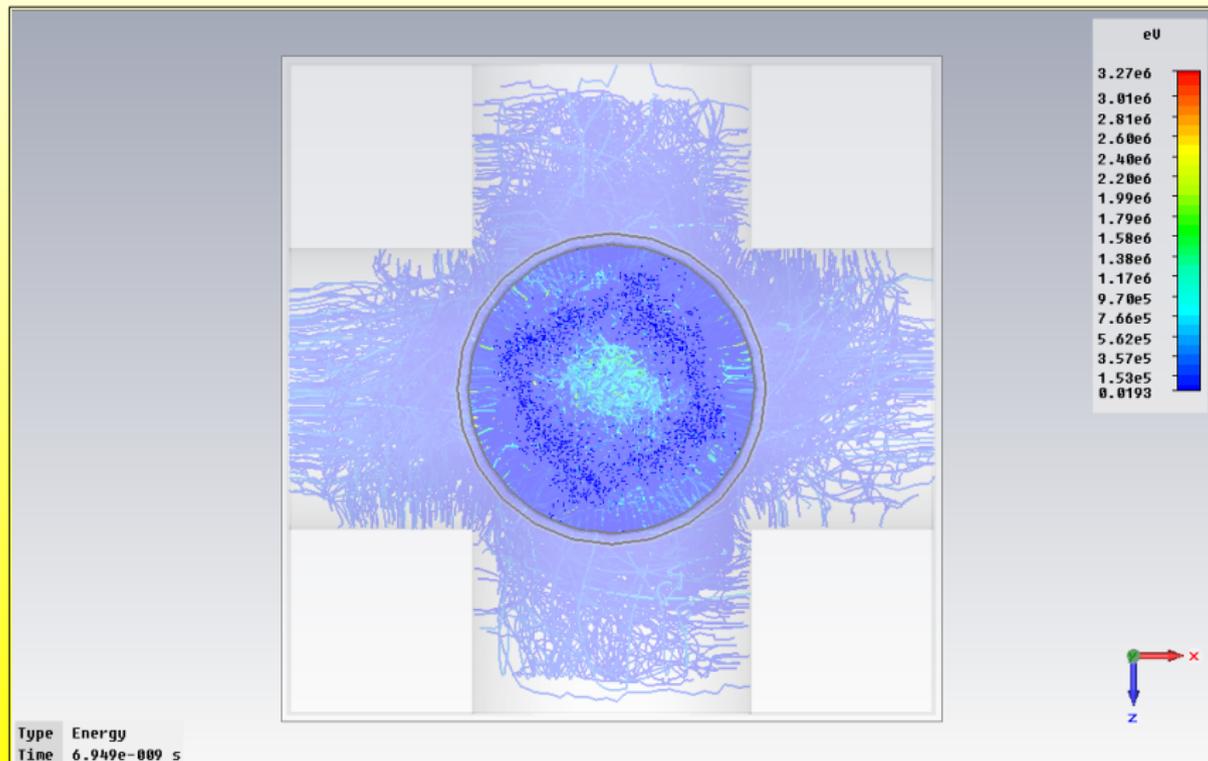
View of the electron trajectories at extraction side



Longitudinal view



View of the electron trajectories



Conclusions

- There is a strong absorption of microwave power at various frequencies whenever the reflection co-efficient showed a minimum value
- The effect was seen for the higher charge states
- The shape of the beam as a function of frequency clearly shows a strong variation at BPM1
- Warm and cold electron components were found to be directly correlated with the beam intensity enhancement in case of Ar^{9+} , not for O^{5+}
- Particle tracking shows the evolution of the quadrupolar structure of the ECR plasma which is modified by the electromagnetic fields in the cavity

Thank You

